## (12) INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

### (19) World Intellectual Property Organization

International Bureau



## ) (A THE BANKAR) IN BARKAR HICH BENA BENA BERA BANK BENA BANK BANK BARK BARKA HICH BARKAR BANK ARE HICH BANK BERA

(43) International Publication Date 28 October 2004 (28.10.2004)

**PCT** 

# (10) International Publication Number WO 2004/092441 A2

(51) International Patent Classification7:

\_\_\_\_

C23C 16/34

(21) International Application Number:

PCT/IB2004/001346

(22) International Filing Date:

8 April 2004 (08.04.2004)

(25) Filing Language:

English

(26) Publication Language:

English

(30) Priority Data:

2003-113118

17 April 2003 (17.04.2003) JF

(71) Applicant (for all designated States except US): L'AIR LIQUIDE, SOCIETE ANONYME A DIRECTOIRE ET CONSEIL DE SURVEILLANCE POUR L'ETUDE ET L'EXPLOITATION DES PROCEDES GEORGES CLAUDE [FR/FR]; 75, quai d'Orsay, F-75321 Paris Cedex 07 (FR).

(72) Inventors; and

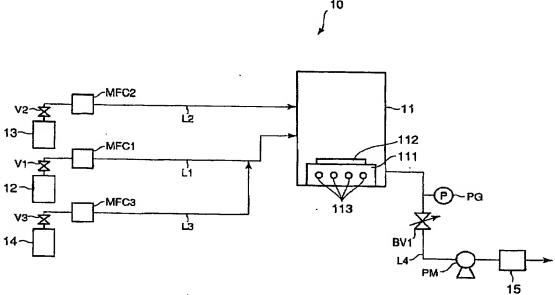
(75) Inventors/Applicants (for US only): DUSSARRAT,
Christian [FR/JP]; Tsukubamatsushiro 4-2-1 #204,
4-15-2, Matsushiro, Tsukuba-shi (JP). GIRARD,
Jean-Marc [FR/FR]; 12, rue Michel Chasles, F-75012

Paris (FR). KIMURA, Takako [JP/JP]; 586-2 Higashi Hiratsuka, Tsukuba-shi, Ibaraki 300-0812 (JP). TAMAOKI, Naoki [JP/JP]; 2-10-5-604 Ishikawa-machi, Oota-ku, Tokyo 145-0061 (JP). SATO, Yuusuke [JP/JP]; Ostuka 6-30-7, Bynkyo-ku, Tokyo 112-0012 (JP).

- (74) Agents: VESIN, Jacques et al.; L'Air Liquide S.A., 75, quai d'Orsay, F-75321 Paris Cedex 07 (FR).
- (81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NA, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.
- (84) Designated States (unless otherwise indicated, for every kind of regional protection available): ARIPO (BW, GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR,

[Continued on next page]

(54) Title: METHODS FOR PRODUCING SILICON NITRIDE FILMS BY VAPOR-PHASE GROWTH



(57) Abstract: To provide a method that is not accompanied by the production of ammonium chloride, avoids significant admixture of carbonaceous contaminants in the film products, and can produce silicon nitride films with improved film properties even at relatively low temperatures. Silicon nitride films are formed on substrates by feeding a hydrazine gas and at least 1 precursor gas selected from the group consisting of trisilylamine gas and a silylhydrazine gas into a reaction chamber (11) that holds at least 1 substrate (112) and inducing the vapor-phase reaction of the two gases. Silylhydrazine gas can also produce silicon nitride films by itself by thermal decomposition.

## WO 2004/092441 A2



GB, GR, HU, IE, IT, LU, MC, NL, PL, PT, RO, SE, SI, SK, TR), OAPI (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

#### Published:

 without international search report and to be republished upon receipt of that report